

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10649797	LEE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chu, Wutchung	2619

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	310, 333, 337	2/1/2008	WC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East search	2/1/2008	WC
Inventorship search	2/1/2008	WC
Consulted with Edan Orgad	2/1/2008	WC
manual search for class 370/310	2/1/2008	WC
updated search	8/14/2008	WC
Consulted with SPE Edan Orgad	8/14/2008	WC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>